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Application/Control	No. Applicant(s)/Patent unde Reexamination	r
10/009,317	SELSTED ET AL.	
Examiner	Art Unit	
Anand U. Desai, Ph	n.D. 1656	

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INTERFERENCE SEARCHED			
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USPAT. S	S-PGPUB, See search printout(s)	12/5/2007	AD

SEARCH NOT (INCLUDING SEARCH)
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STIC sequence search. See SCORES database. SEQ ID NO: 32 and SEQ ID NO: 33.	12/3/2007	AD
EAST – US-PGPUB, USPAT, EPO, JPO, DERWENT. See search history printout(s).	12/4/2007	AD
EAST – US-PGPUB, USPAT, EPO, JPO, DERWENT. See search history printout(s).	12/5/2007	AD
Inventor and Assignee search	12/5/2007	AD
PubMed search (see search history printout(s).	12/5/2007	AD
Consulted with Examiner A. Navarro	12/3/2007	AD